

Examiner-Initiated Interview Summary	Application No.	Applicant(s)	
	10/599,539	FUJII ET AL.	
	Examiner ALLISON BOURKE	Art Unit 1725	

All participants (applicant, applicant's representative, PTO personnel):

(1) ALLISON BOURKE. (3) _____.

(2) Lawrence McClure. (4) _____.

Date of Interview: 09 May 2012.

Type: Telephonic Video Conference
 Personal [copy given to: applicant applicant's representative]

Exhibit shown or demonstration conducted: Yes No.
If Yes, brief description: _____.

Issues Discussed 101 112 102 103 Others

(For each of the checked box(es) above, please describe below the issue and detailed description of the discussion)

Claim(s) discussed: _____.

Identification of prior art discussed: _____.

Substance of Interview

(For each issue discussed, provide a detailed description and indicate if agreement was reached. Some topics may include: identification or clarification of a reference or a portion thereof, claim interpretation, proposed amendments, arguments of any applied references etc...)

Mr. McClure gave an explanation of how the data given in the remarks was unexpected, including showing the difference in Fill Factor or Efficiency of the 2 bus bar arrangement (single cell vs. module) is greater than the difference in Fill factor or efficiency of the 3 bus bar arrangement.

Applicant recordation instructions: It is not necessary for applicant to provide a separate record of the substance of interview.

Examiner recordation instructions: Examiners must summarize the substance of any interview of record. A complete and proper recordation of the substance of an interview should include the items listed in MPEP 713.04 for complete and proper recordation including the identification of the general thrust of each argument or issue discussed, a general indication of any other pertinent matters discussed regarding patentability and the general results or outcome of the interview, to include an indication as to whether or not agreement was reached on the issues raised.

Attachment

/A. B./ Examiner, Art Unit 1725	/Basia Ridley/ Supervisory Patent Examiner, Art Unit 1725
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